Multi-Element Array Series

Planar Diffused Silicon Photodiodes

Multichannel array photodetectors consist of a number of single element photodiodes laid adjacent to each other forming a one-dimensional sensing area on a common cathode substrate. They can perform simultaneous measurements of a moving beam or beams of many wavelengths. They feature low electrical cross talk and super high uniformity between adjacent elements allowing very high precision measurements. Arrays offer a low cost alternative when a large number of detectors are required. The detectors are optimized for either UV, visible or near IR range.

They can be either operated in photoconductive mode (reverse biased) to decrease the response time, or in photovoltaic mode (unbiased) for low drift applications. A2V-16 can be coupled to any scintillator crystal for measuring high-energy photons in the X-ray and g-ray region of electromagnetic spectrum. In addition, they have been mechanically designed, so that several of them can be mounted end to end to each other in applications where more than 16 elements are needed.

Figure 11 in the "Photodiode Characteristics" section of this catalog provides a detailed circuit example for the arrays.



APPLICATIONS

- Level Meters
- Optical Spectroscopy
- Medical Equipment
- High Speed Photometry
- Computed Tomography Scanners
- Position Sensors

FEATURES

- Common Substrate Array
- Ultra Low Cross Talk
- UV Enhanced (A5V-35UV)
- Low Dark Current
- Low Capacitance
- Solderable





Typical Spectral Response



Typical Electro-Optical Specifications at T_A=23°C

Model Number	Number of Elements	Active Area Per Element		Ê	Responsivity (A/W)	Shunt Resistance (MΩ)	Shunt Resistance (MΩ)Dark Current (pF)		Capacitance (pF)		N (W /	EP √Hz)	z) Tem Rang (°C				
		Area (mm²)	Dimensions (mm)	Pitch (m	970nm	-10 mV	-1	0 V	0 V	-10	v	0 V 970nm	-10 V 970nm	rating	rage	Package Style ¶	
					typ.	typ.	ty	/p.	typ.			min.	typ.	Ope	Sto		
Photoconductive Arrays																	
A5C-35	35	3.9	4.39 x 0.89	0.99	0.65		0.	05		12	2		6.2 e-15			54 / 40 pin DIP	
Photovoltaic Arrays																	
A2V-16	16	1.92	1.57 x 1.2	2 1.59	0.60	1000	-		170		-	4.8 e-15		+85	125	53 / PCB	
A5V-35	35	3.9	4.39 x 0.89	9 0.99	0.60	1000	l		340			4.8 0-15		~	+ 2	54 / 40 pip DIP	
A5V-38	38				0.00	1000			540			4.0 6-13		ē,	-40	54 / 40 pin DIr	
A2V-76	76	1.8	6.45 x 0.2	3 0.31	0.50	500	-		160		-	8.2 e-15	;			52 / Ceramic	
UV Enhai	nced A	rray	(All Spe	cificatio	ons @ λ =25	54 nm, V _{BI}	_{AS} = -	-10V))								
A5V-35UV	35	3.9	4.39 x 0.89	0.99	0.06**	500	-		340		-	6.8 e-14		1		54 / 40 pin DIP	
		r															
Model Number	Number of Elements	Element Size		Active Ar per Eleme	ea Pitch	Respons (A/W	Responsivity (A/W)		Open Circuit oltage/Element (mV)		R	Shunt esistance (MΩ)	Capacitance (pF)		e		
		Number of Elements		mm (mm²)		mm	970ni	970nm 10		mW/cm2 2850 °K		-10 mV		οv			
		(inches)		(inches) (inches)	typ.	typ.		typ.		typ.		typ.				

Monolithic Solderable Chip Arrays (Typical Electro-Optical Specifications at $T_A = 23$ °C)												
A4V-2	2											
A4V-4	4	1.52 x 2.79 (0.06 x 0.110)	4.24 (0.007)	1.90 (0.075)	0.6		1000	500				
A4V-6	6					F00						
A4V-8	8					500						
A4V-10	10]										
A4V-12	12]										

The chips are equipped with 2" long bare tinned leads soldered to all anodes and the common cathode.

'V' suffix indicates the device is optimized for 'photoconductive' operation.
'C' suffix indicates the device is optimized for 'photoconductive' operation.
'For mechanical drawings please refer to pages 58 thru 69.
* Non-Condensing temperature and Storage Range, Non-Condensing Environment.

** $\lambda = 254 \text{ nm}$



1. Parameter Definitions:

- A = Distance from top of chip to top of glass.
- a = Photodiode Anode.
- B = Distance from top of glass to bottom of case.
- c = Photodiode Cathode
 - (Note: cathode is common to case in metal package products unless otherwise noted).
- W = Window Diameter.
- F.O.V. = Filed of View (see definition below).

2. Dimensions are in inches (1 inch = 25.4 mm).

3. Pin diameters are 0.018 ± 0.002" unless otherwise specified.

4. Tolerances (unless otherwise noted) General: 0.XX ±0.01" 0.XXX ±0.005" Chip Centering: ±0.010"

Dimension 'A': ± 0.015 "

5. Windows

All '**UV**' Enhanced products are provided with QUARTZ glass windows, 0.027 \pm 0.002" thick.

All 'XUV' products are provided with removable windows.

All '**DLS**' PSD products are provided with A/R coated glass windows.

All 'FIL' photoconductive and photovoltaic products are epoxy filled instead of glass windows.





Mechanical Specifications and Die Topography

For Further Assistance Please Call One of Our Experienced Sales and Applications Engineers

310-978-0516

- Or -On the Internet at WWW.OSioptoelectronics.com

Mechanical Specifications

All units in inches. Pinouts are top view.

